TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

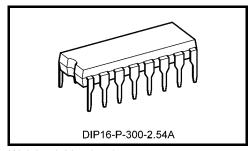
# **TC4521BP**

## TC4521BP 24-Stage Frequency Divider

TC4521BP is frequency divider consisting of 24 stages of flip-flop. The input section is equipped with an inverter to enable to use either RC oscillator circuit or crystal oscillator circuit and to accept pulse from external clock source.

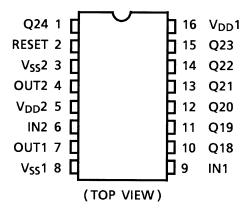
Each flip-flop is inverted by the falling edge of the output of previous stage flip-flop and this can count up to the maximum of  $2^{24}=16,777,216$ .

Since six outputs,  $2^{18}$ ,  $2^{19}$ ,  $2^{20}$ ,  $2^{21}$ ,  $2^{22}$ , and  $2^{23}$  are available besides of  $2^{24}$ , adjustment of frequency divided output can be achieved.



Weight: 1.00 g (typ.)

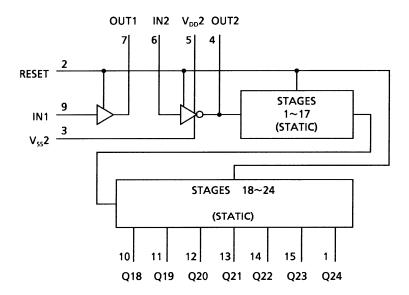
### **Pin Assignment**



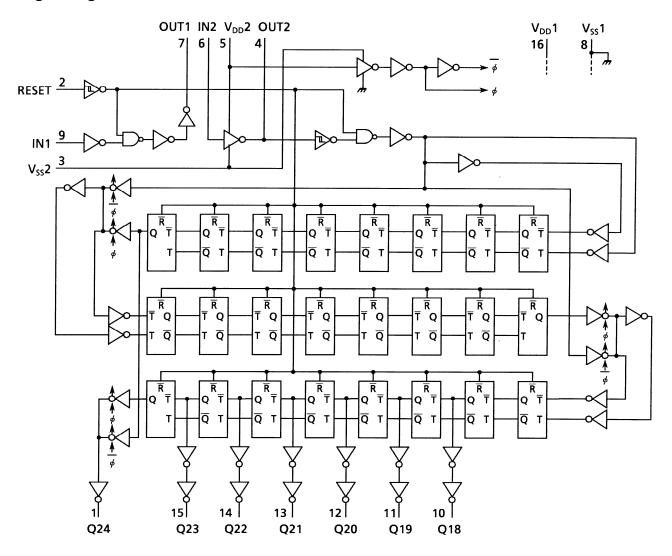
### **Count Capacity**

Output	Count Capacity		
Q18	$2^{18} = 262,144$		
Q19	$2^{19} = 524,288$		
Q20	$2^{20} = 1,048,576$		
Q21	$2^{21} = 2,097,152$		
Q22	$2^{22} = 4,194,304$		
Q23	$2^{23} = 8,388,608$		
Q24	$2^{24} = 16,777,216$		

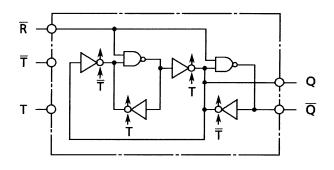
# **Block Diagram**



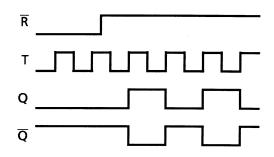
# **Logic Diagram**



## **Internal Flip Flop Logic Diagram**



## **Flip Flop Timing Chart**



### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
DC supply voltage	V <sub>DD</sub> 1	$V_{SS}1 - 0.5$ to $V_{SS}1 + 20$	V
Do supply voltage	V <sub>DD</sub> 2	$V_{SS}1 - 0.5$ to $V_{DD}1 + 0.5$	v
Input voltage	V <sub>IN</sub>	$V_{SS}1 - 0.5$ to $V_{DD}1 + 0.5$	٧
Output voltage	V <sub>OUT</sub>	$V_{SS}1 - 0.5$ to $V_{DD}1 + 0.5$	V
DC input current	I <sub>IN</sub>	±10	mA
Power dissipation	PD	300	mW
Operating temperature range	T <sub>opr</sub>	-40 to 85	°C
Storage temperature range	T <sub>stg</sub>	–65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

# Operating Ranges (V<sub>SS</sub>1 = V<sub>SS</sub>2 = 0 V) (Note)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
DC supply voltage	V <sub>DD</sub> 1, V <sub>DD</sub> 2	_	3	_	18	V
Input voltage	V <sub>IN</sub>	_	0		V <sub>DD</sub> 1	V

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Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ .

# Static Electrical Characteristics ( $V_{SS}1 = V_{SS}2 = 0 \text{ V}, V_{DD}1 = V_{DD}2$ )

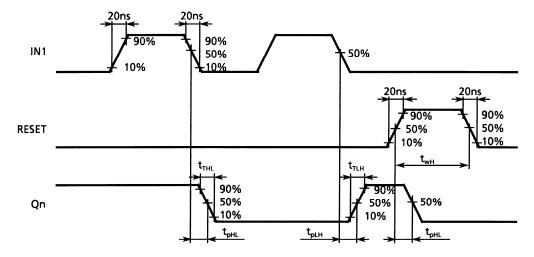
S		Sym- Test Condition			-40°C		25°C			85°C		
Charac	teristics	bol		V <sub>DD</sub> (V)	Min	Max	Min	Тур.	Max	Min	Max	Unit
High-level voltage	output	V <sub>OH</sub>	$ I_{OUT}  < 1 \mu A$ $V_{IN} = V_{SS}, V_{DD}$	5 10	4.95 9.95	_ _	4.95 9.95	5.00 10.00	_ _	4.95 9.95	_ _	٧
			*IN *33, *DD	15	14.95	_	14.95	15.00	_	14.95	_	
<b>.</b>			  I <sub>OUT</sub>   < 1 μA	5	_	0.05	_	0.00	0.05	_	0.05	
Low-level voltage	output	$V_{OL}$	$V_{IN} = V_{SS}, V_{DD}$	10	_	0.05	_	0.00	0.05	_	0.05	V
			VIN - VSS, VDD	15		0.05	_	0.00	0.05	_	0.05	
			V <sub>OH</sub> = 4.6 V	5	-0.61		-0.51	-1.0	_	-0.42	_	
			V <sub>OH</sub> = 2.5 V	5	-2.5	_	-2.1	-4.0	_	-1.7	_	
Output hig	h current	I <sub>OH</sub>	V <sub>OH</sub> = 9.5 V	10	-1.5	_	-1.3	-2.2	_	-1.1	_	mA
			V <sub>OH</sub> = 13.5 V	15	-4.0	_	-3.4	-9.0	_	-2.8	_	
			$V_{IN} = V_{SS}, V_{DD}$									
			V <sub>OL</sub> = 0.4 V	5	0.61		0.51	1.2	_	0.42	_	
0			V <sub>OL</sub> = 0.5 V	10	1.5	_	1.3	3.2	_	1.1	_	
Output low current	l <sub>OL</sub>	V <sub>OL</sub> = 1.5 V	15	4.0	_	3.4	12.0	_	2.8	_	mA	
		$V_{IN} = V_{SS}, V_{DD}$										
			V <sub>OUT</sub> = 0.5 V, 4.5 V	5	3.5	_	3.5	2.75	_	3.5	_	
		.,	V <sub>OUT</sub> = 1.0 V, 9.0 V	10	7.0	_	7.0	5.5	_	7.0	_	V
Input high	voltage	$V_{IH}$	V <sub>OUT</sub> = 1.5 V, 13.5 V	15	11.0	_	11.0	8.25	_	11.0	_	
			I <sub>OUT</sub>   < 1 μA									
			V <sub>OUT</sub> = 0.5 V, 4.5 V	5		1.5	_	2.25	1.5	_	1.5	
			V <sub>OUT</sub> = 1.0 V, 9.0 V	10	_	3.0	_	4.5	3.0	_	3.0	
Input low voltage V	V <sub>IL</sub>	V <sub>OUT</sub> = 1.5 V, 13.5 V	15	_	4.0	_	6.75	4.0	_	4.0	V	
		I <sub>OUT</sub>   < 1 μA										
Input	Input "H" level I <sub>IH</sub>	l <sub>IH</sub>	V <sub>IH</sub> = 18 V	18		0.1	_	10 <sup>-5</sup>	0.1	_	1.0	^
current	"L" level	I <sub>IL</sub>	V <sub>IL</sub> = 0 V	18	_	-0.1	_	-10 <sup>-5</sup>	-0.1	_	-1.0	μΑ
					_	5	_	0.005	5	_	150	
Quiescent supply current		oly I <sub>DD</sub>	$V_{IN} = V_{SS}, V_{DD}$ (Note)	10	_	10	_	0.010	10	_	300	μА
- 3	Current		(Note)	15	_	20	_	0.015	20		600	

Note: All valid input combinations.

# Dynamic Electrical Characteristics (Ta = 25°C, $V_{SS}1 = V_{SS}2 = 0$ V, $V_{DD}1 = V_{DD}2$ , $C_L = 50$ pF)

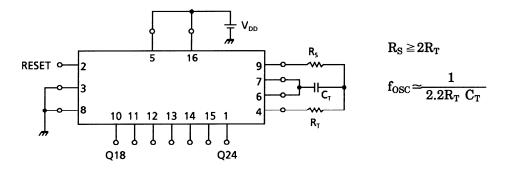
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
onardotonous	Symbol		V <sub>DD</sub> (V)		1 3 17	Max	Onit
Output transition time			5	_	70	200	
(low to high)	tTLH	_	10	_	35	100	ns
(low to riigit)			15	_	30	80	
Output transition time			5	_	70	200	
(high to low)	t <sub>THL</sub>	_	10	_	35	100	ns
(High to low)			15	_	30	80	
Propagation delay time	<b>.</b>		5	_	1.1	9.0	
(IN2-Q18)	t <sub>pLH</sub>	_	10	_	0.5	3.5	μS
(IIVZ-Q10)	t <sub>pHL</sub>		15	_	0.3	2.7	
Propagation delay time	<b>.</b>		5	_	1.4	12	
(IN2-Q24)	t <sub>pLH</sub>	_	10	_	0.6	4.5	μS
(INZ-Q24)	t <sub>pHL</sub>		15	_	0.4	3.5	
Propagation delay time			5	_	220	2600	
(RESET-Qn)	t <sub>pHL</sub>	_	10	_	100	1000	ns
(NESET-QII)			15	_	70	750	
	f <sub>CL</sub>	_	5	3	9.5	_	
Max clock frequency			10	6	17.5	_	MHz
			15	8	23.5	_	
Max clock input rise time	+		5	No limit			μS
Max clock input fall time	trCL	_	10				
Max Clock Input fall time	t <sub>fCL</sub>		15				
Min clock pulse width		_	5	_	55	385	
	t <sub>W</sub>		10	_	25	150	ns
			15	_	16	120	
Min nulca width			5	_	60	385	
Min pulse width	t₩H	_	10	_	26	150	ns
(RESET)			15	_	20	120	
Input capacitance	C <sub>IN</sub>	_		_	5	7.5	pF

# **Waveforms for Measurement of Dynamic Characteristics**

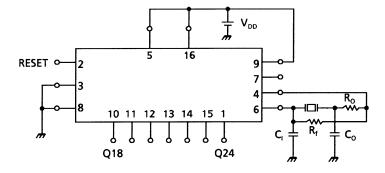


# **Application Circuit**

#### When CR Oscillation is Used as Time Reference



### When Crystal Oscillation is Used as the Time Reference



### **Typical Data**

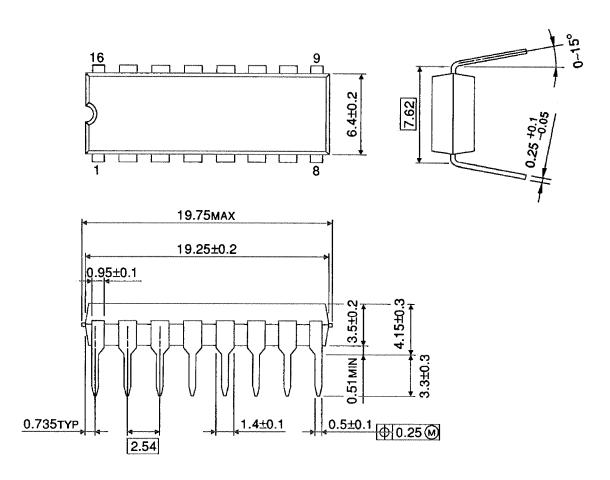
X'tal (Hz)	C <sub>I</sub> , C <sub>O</sub> (pF)	R <sub>O</sub> (Ω)
32.768 k	23	500 k
100 k	60	100 k
1 M	45 to 50	100
4.194304 M	12 to 15	0

 $R_f=10\ M\Omega$ 

# **Package Dimensions**

**TOSHIBA** 

DIP16-P-300-2.54A Unit: mm



Weight: 1.00 g (typ.)

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